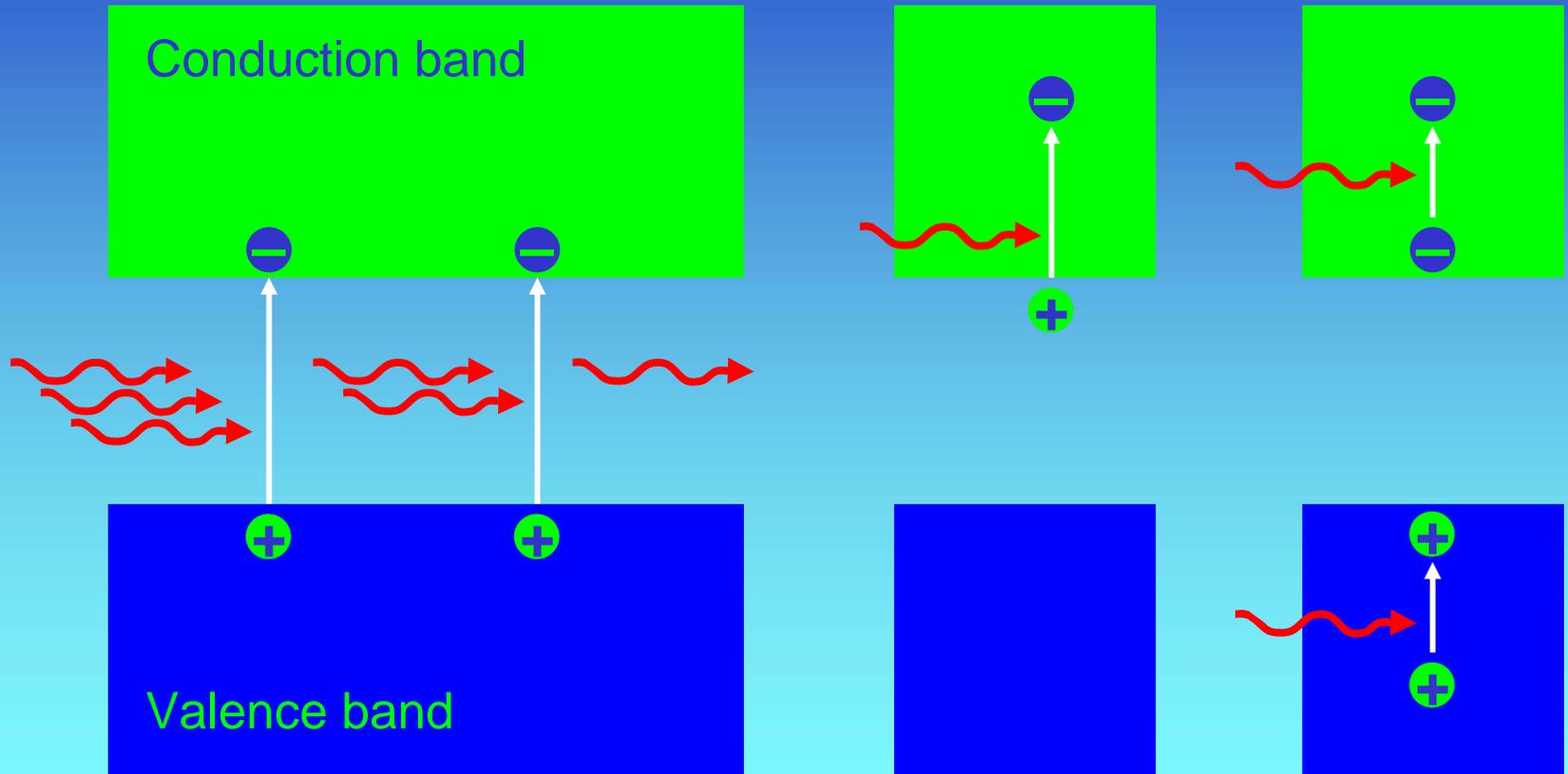


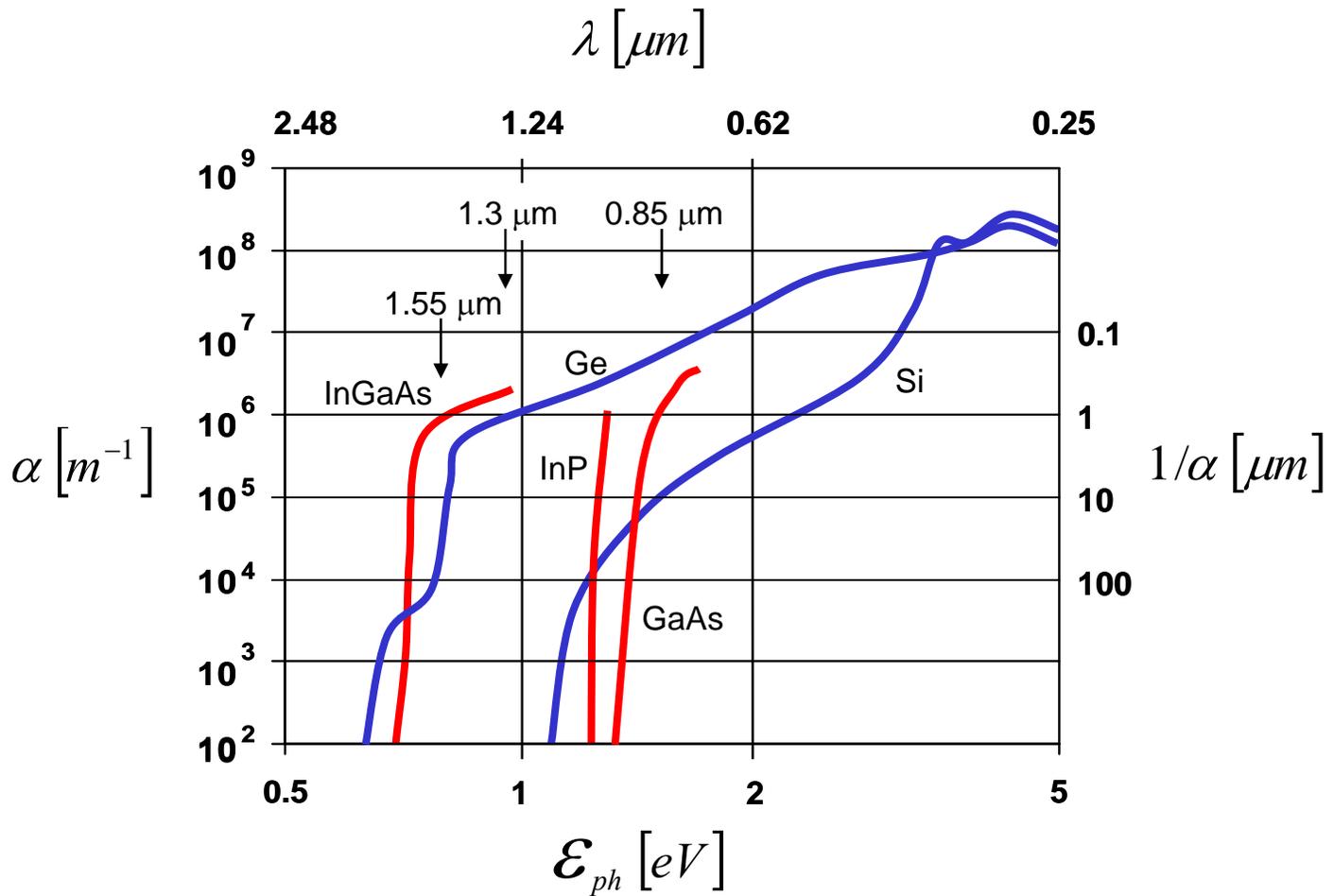
Detectors

- pn photodiodes
- p-i-n photodiodes
- Avalanche photodiodes
- Solar cells

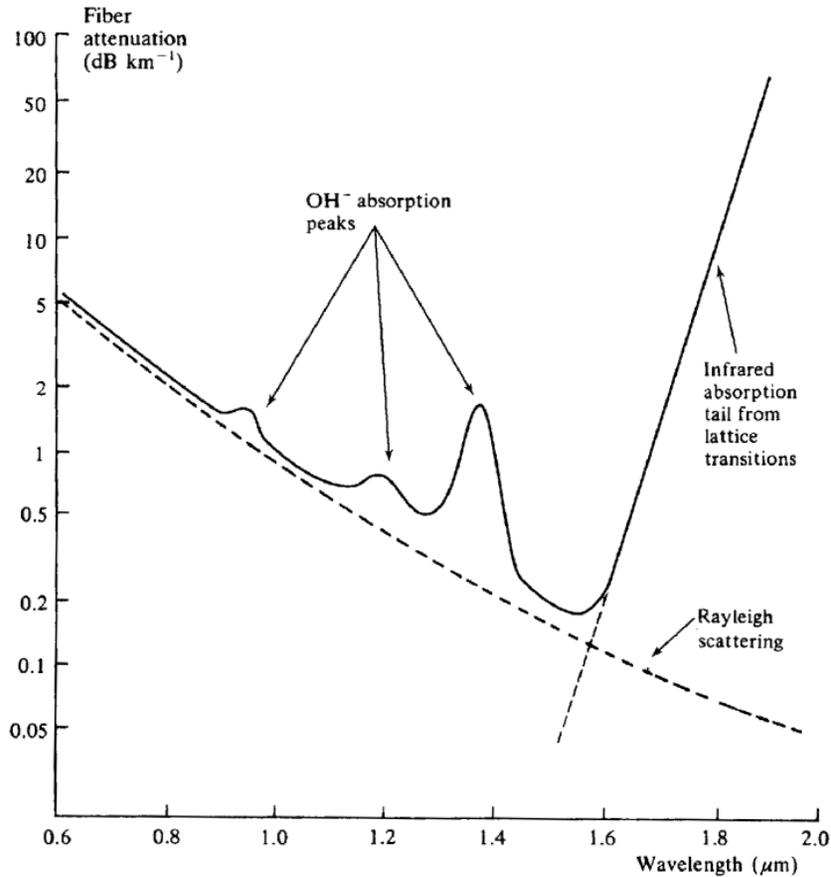
Photon absorption processes



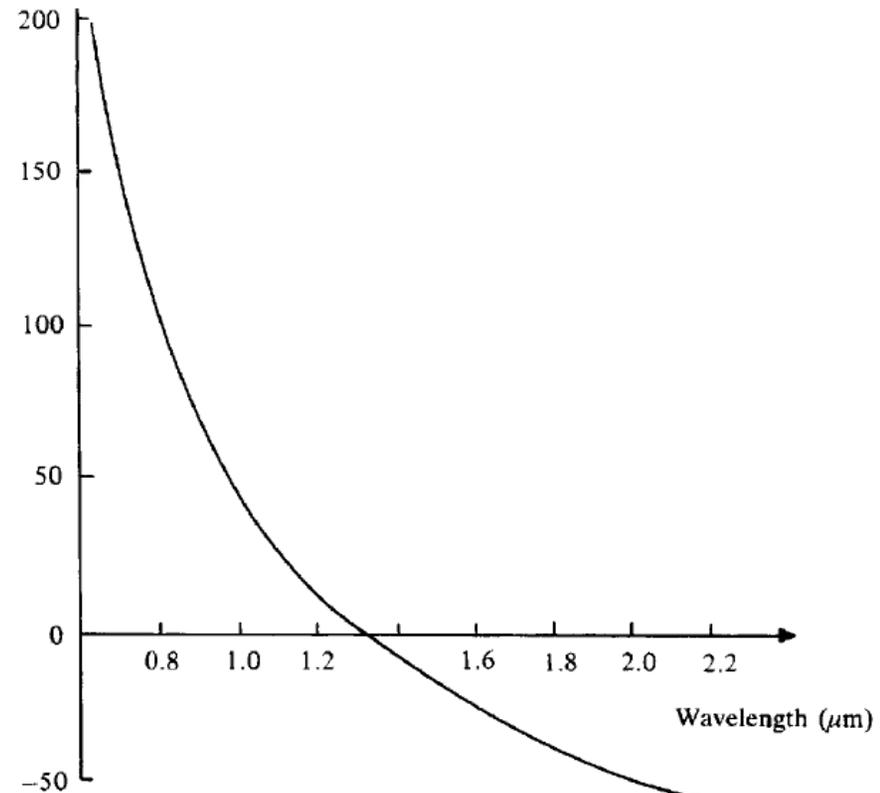
Material absorption



Fibre dispersion and loss

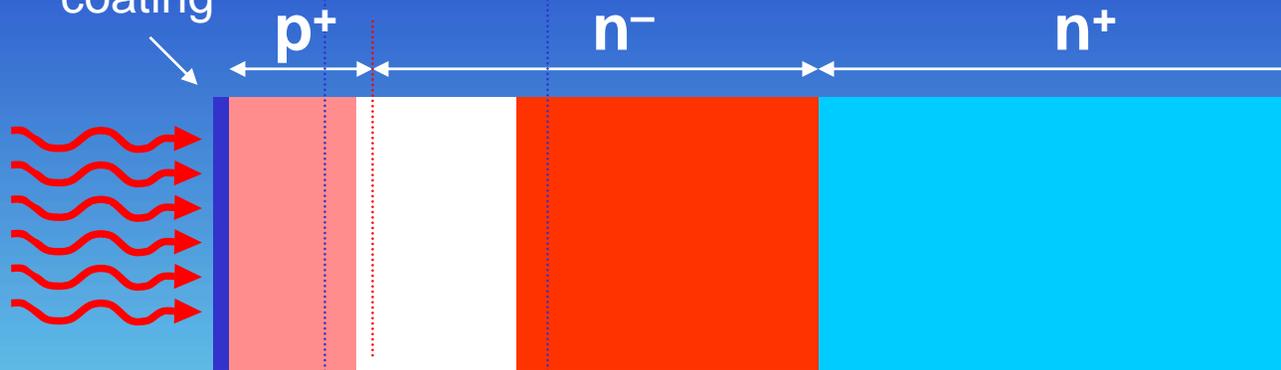


Material dispersion ($\text{ps nm}^{-1} \text{ km}^{-1}$)



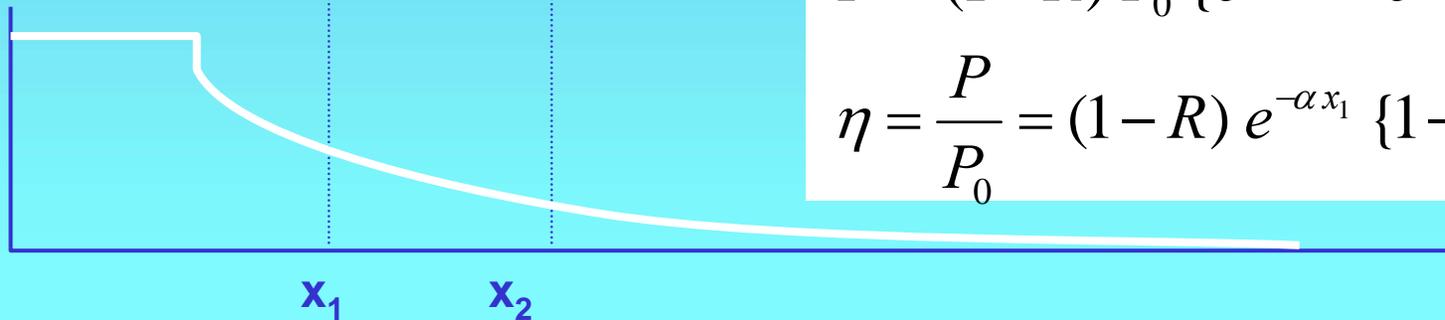
pn-photodiode

anti reflection coating



diffusion length
depletion region

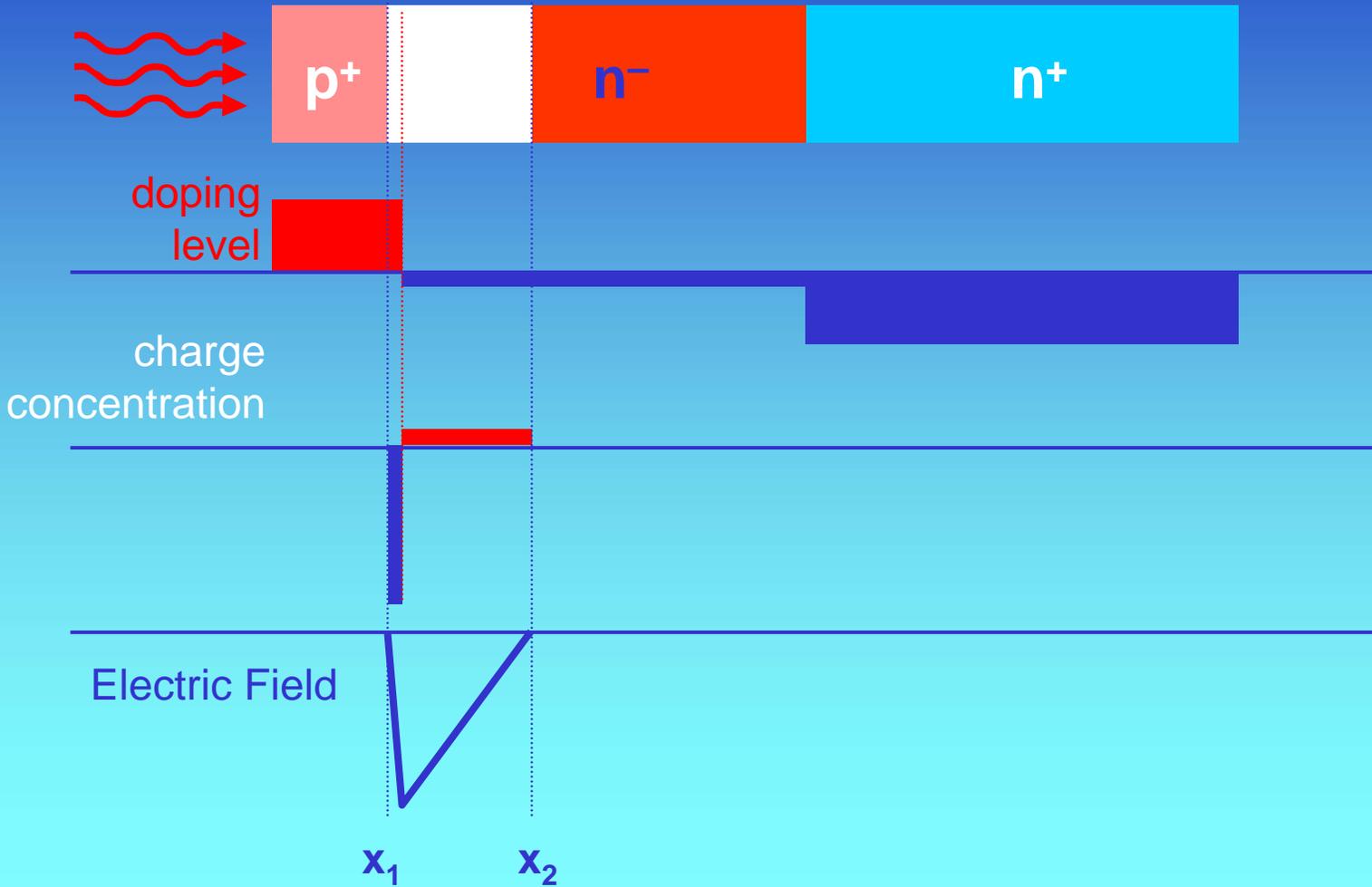
intensity



$$P = (1 - R) P_0 \{ e^{-\alpha x_1} - e^{-\alpha x_2} \}$$

$$\eta = \frac{P}{P_0} = (1 - R) e^{-\alpha x_1} \{ 1 - e^{-\alpha(x_2 - x_1)} \}$$

pn-photodiode



pn-photodiode

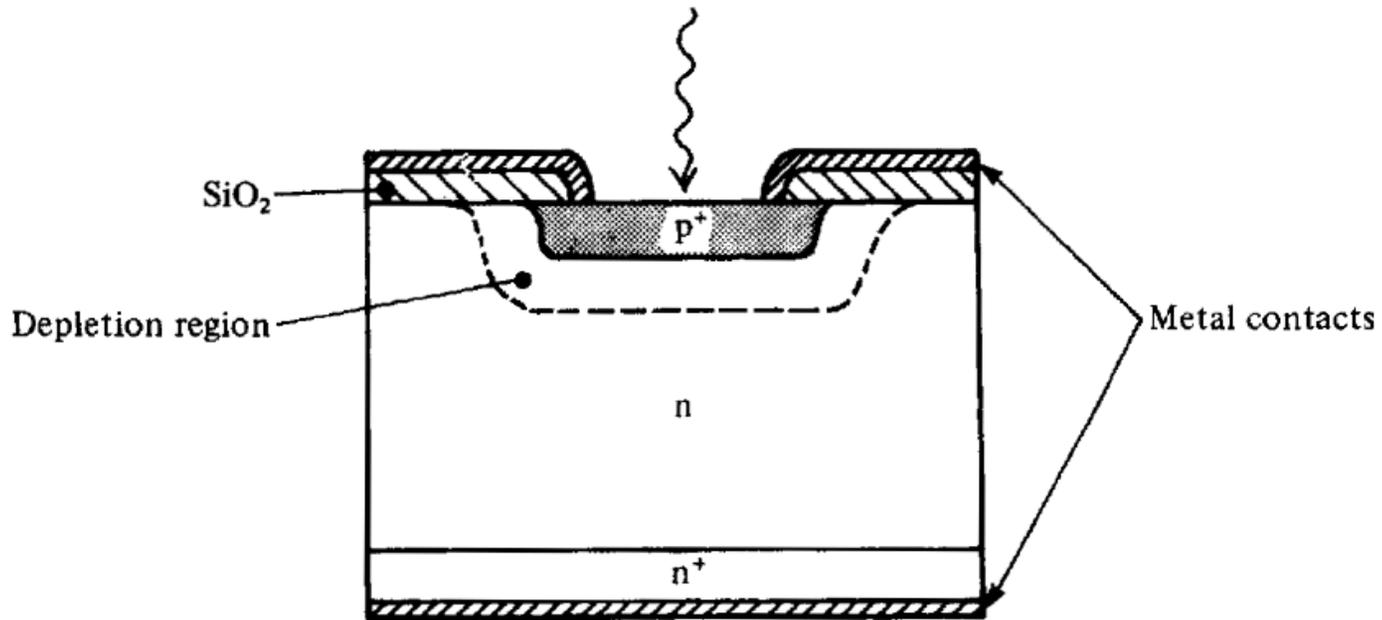


Figure 5.9 Typical silicon photodiode structure for photoconductive operation. A junction is formed between heavily doped p-type material (p^+) and fairly lightly doped n-type material so that the depletion region extends well into the n-type material. The p^+ layer is made fairly thin. Metallic contacts can be made directly to the p^+ material, but to obtain an ohmic contact to the n-type material an intermediate n^+ layer must be formed.

current generation

The current generated by a beam of light with power P and photon energy $h\nu$ is:

$$i_P = \frac{q\eta P}{h\nu}$$

where η is the fraction of photons that generate e-h pairs. The new drift current is $i_0 + i_P$, and so the diffusion current must also increase in order to bring the junction back to equilibrium. If the change in junction voltage is ΔV_J the diffusion current becomes:

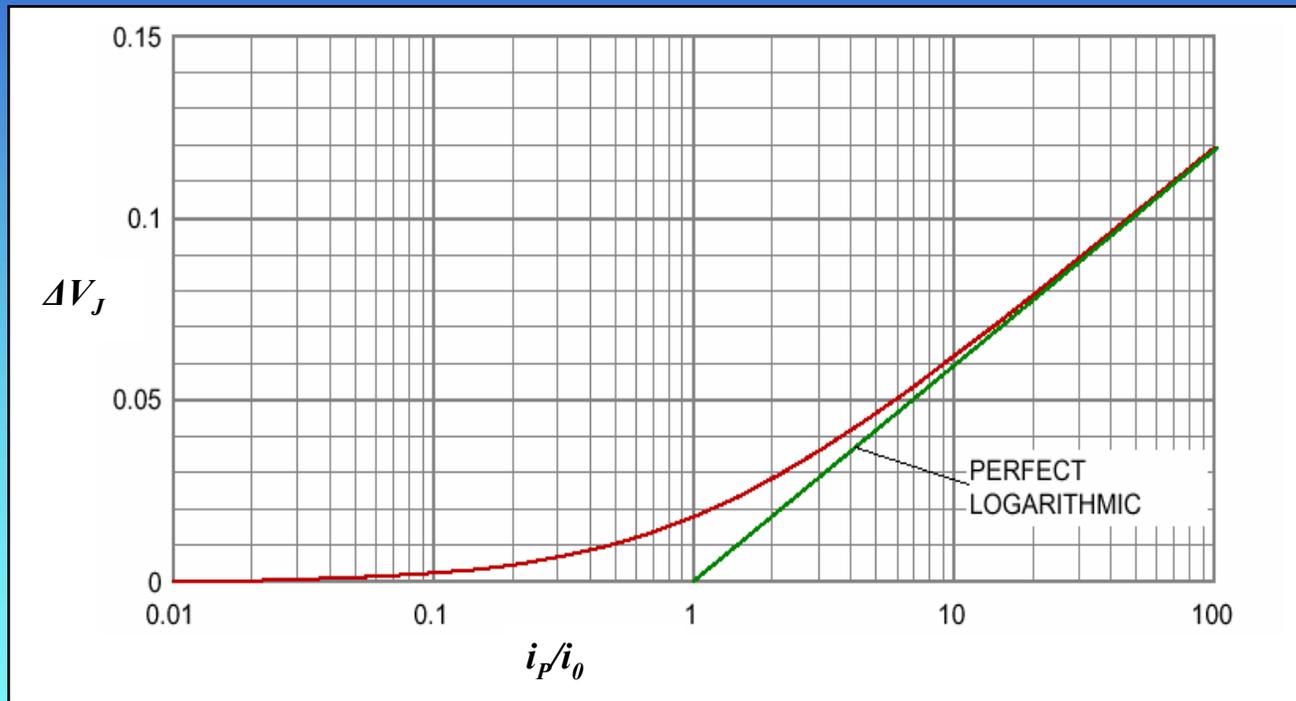
$$i_D = i_0 \exp\left(\frac{q\Delta V_J}{k_B T}\right)$$

Consequently

$$i_0 + i_P = i_0 \exp\left(\frac{q\Delta V_J}{k_B T}\right) \quad \Delta V_J = \frac{k_B T}{q} \ln\left(\frac{i_P}{i_0} + 1\right)$$

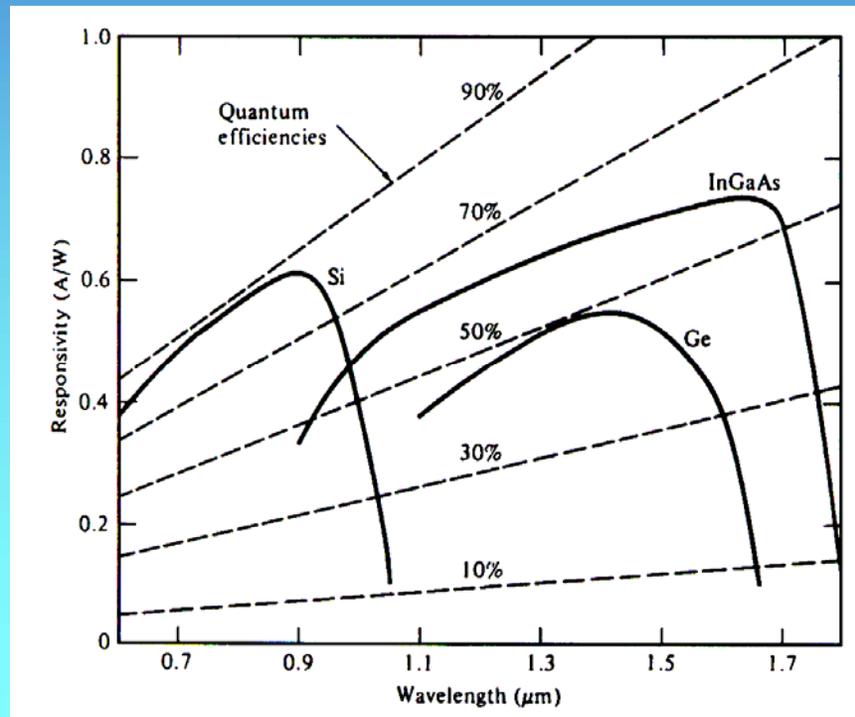
Thus the open circuit voltage increases logarithmically with power at high power.

Open circuit voltage

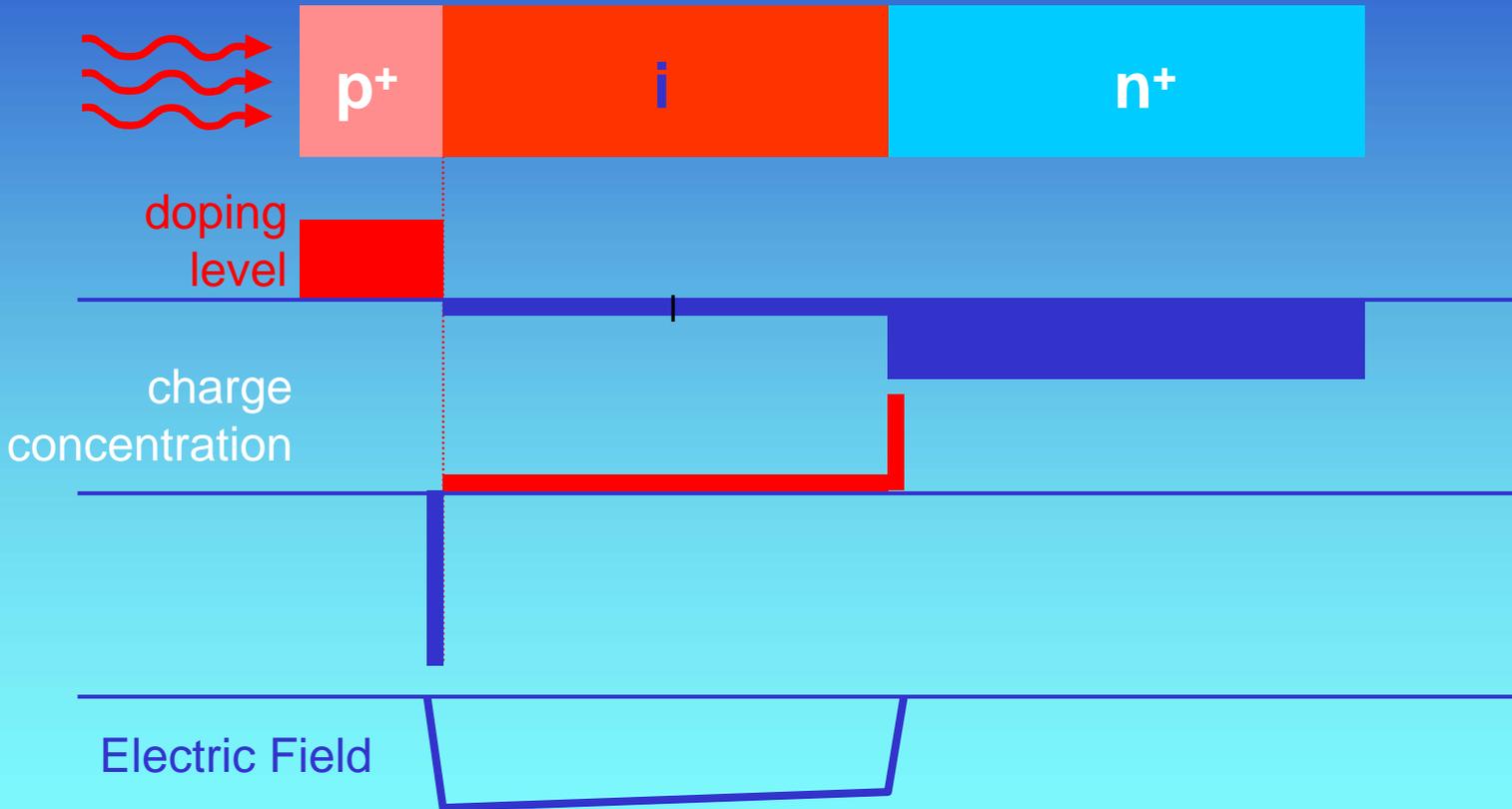


pn-responsivity

$$R = \frac{i_p}{P} = \frac{q\eta}{h\nu} = \frac{\eta\lambda}{1.24} \text{ amps watt}^{-1}$$

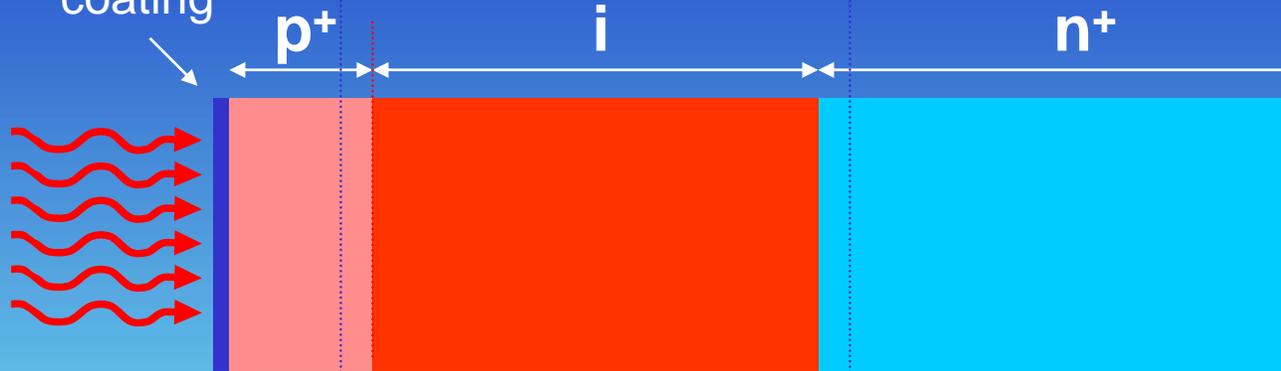


p-i-n photodiode

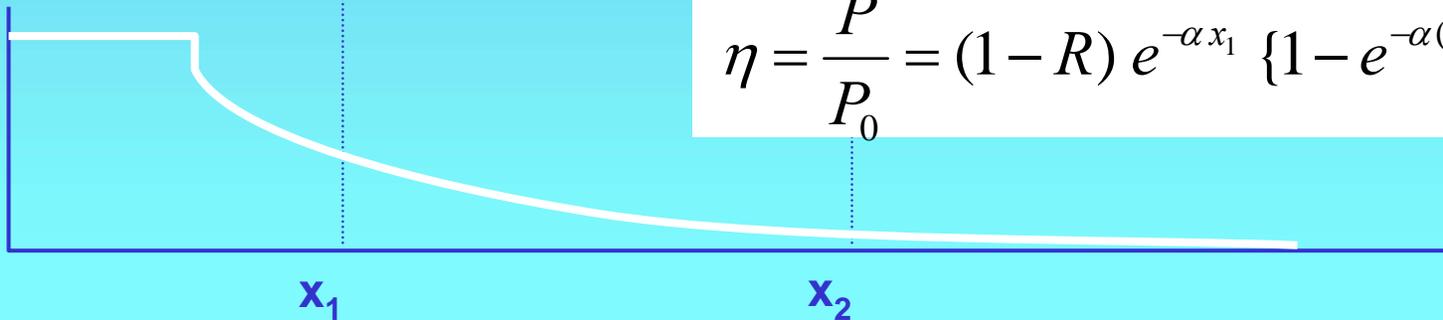


p-i-n photodiode

anti reflection coating



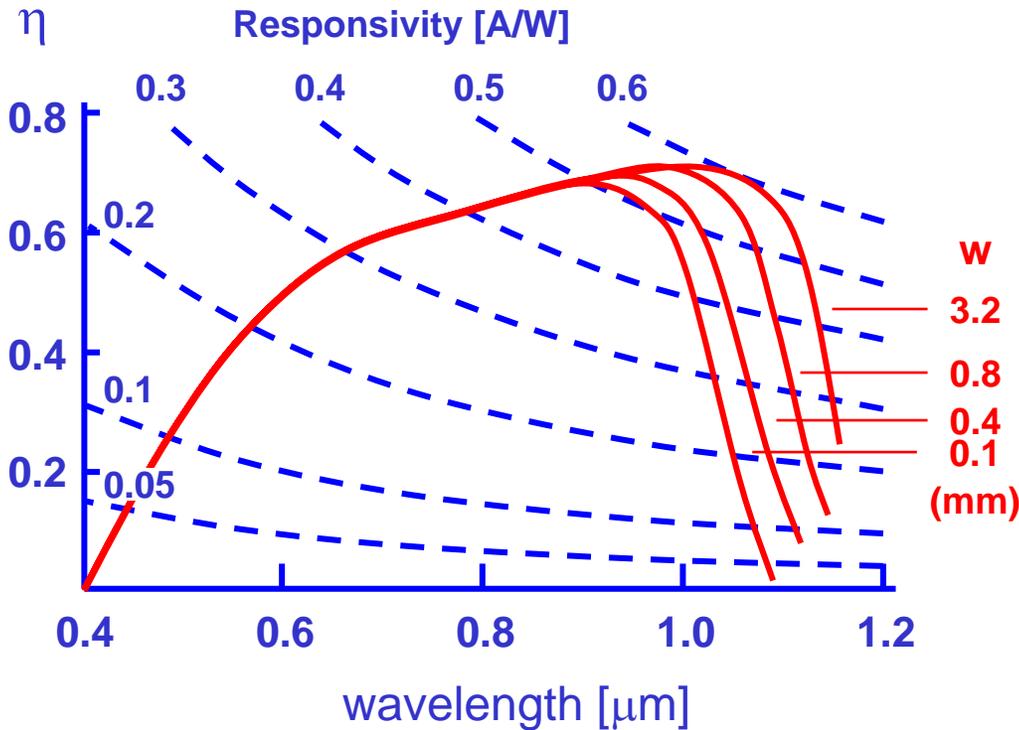
intensity



$$P = (1 - R) P_0 \{ e^{-\alpha x_1} - e^{-\alpha x_2} \}$$

$$\eta = \frac{P}{P_0} = (1 - R) e^{-\alpha x_1} \{ 1 - e^{-\alpha(x_2 - x_1)} \}$$

p-i-n responsivity



Responsivity:

$$R = \frac{I}{P} \text{ [A/W]}$$

$$\eta = \frac{n_e}{n_{ph}} = \frac{I/e}{P/\epsilon_{ph}}$$

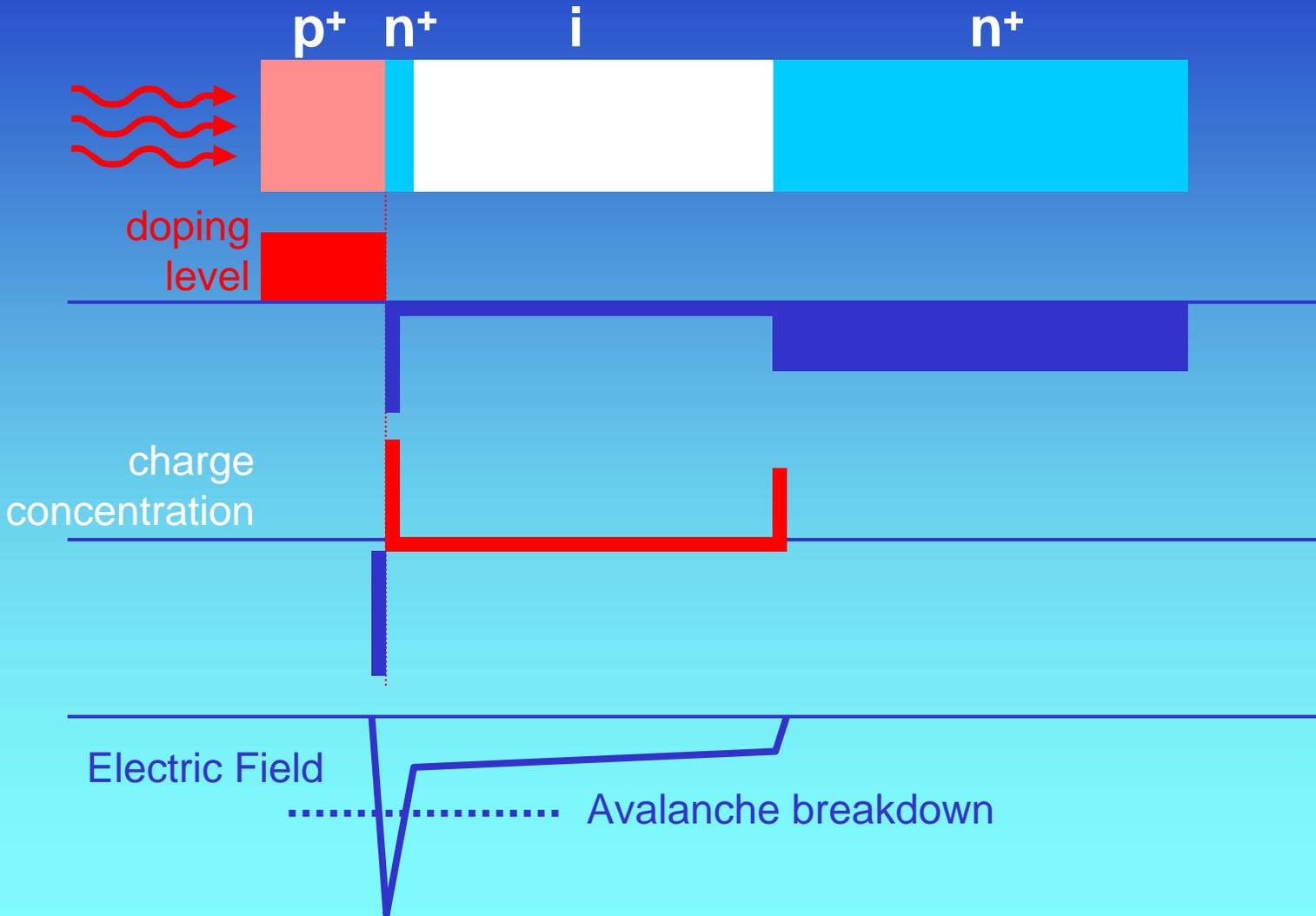
$$\eta = R \frac{\epsilon_{ph}}{e} = R \frac{1.24}{\lambda}$$

$$\epsilon_{ph} = \frac{hc}{e\lambda} = \frac{1.24}{\lambda[\mu\text{m}]}$$

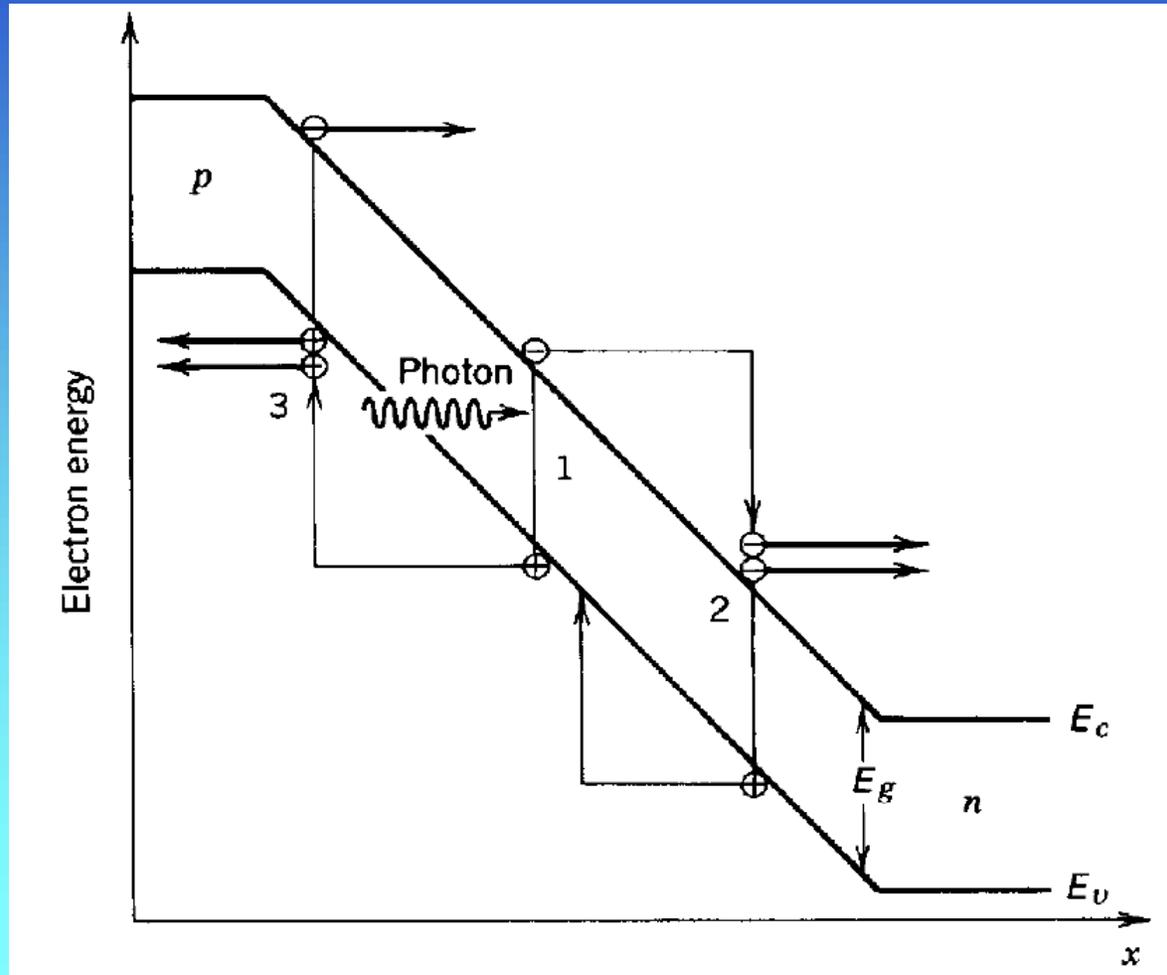
Useful Web Resource

- <http://ece-www.colorado.edu/~bart/book/movie/movie2.htm>

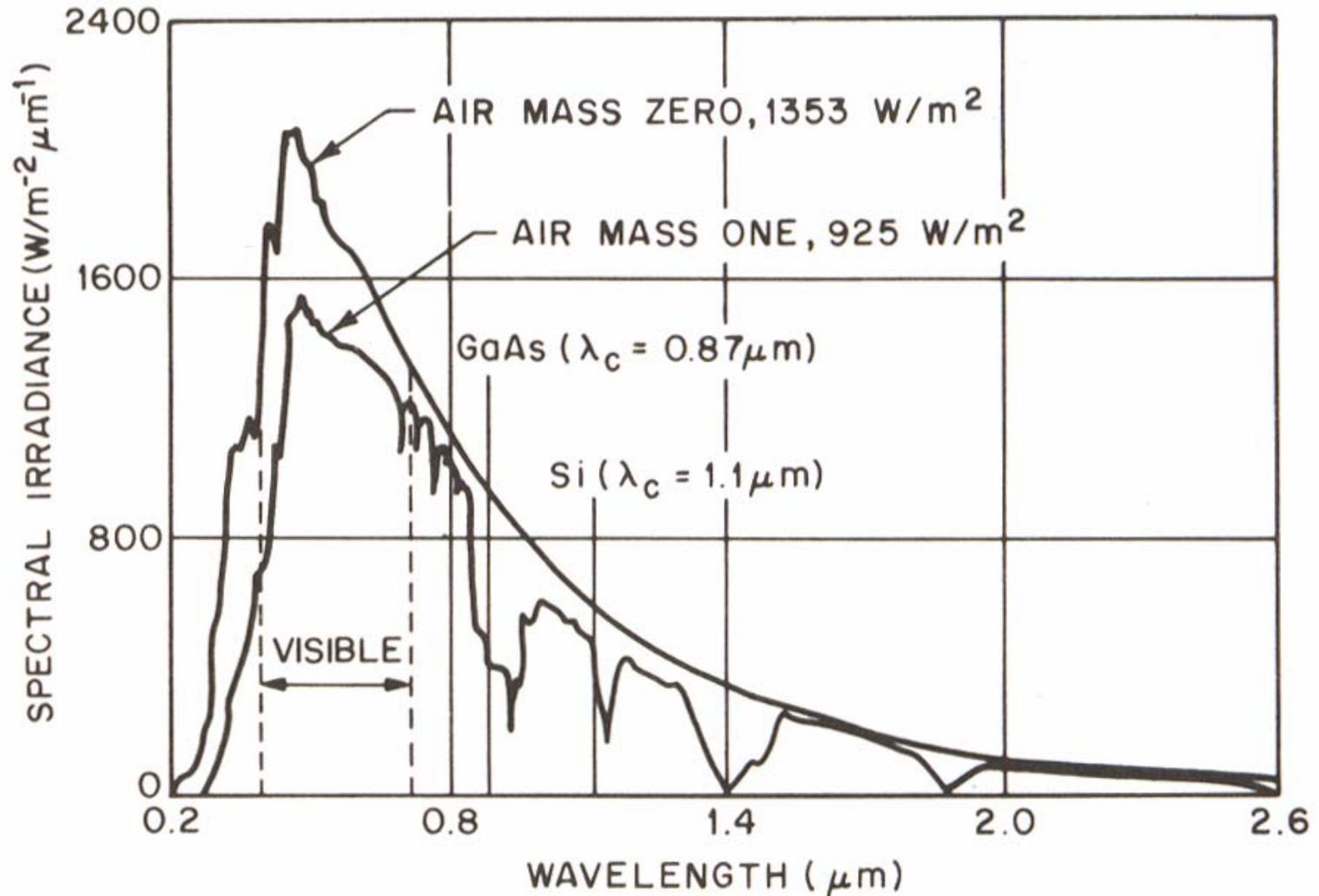
Avalanche-photodiode (APD)



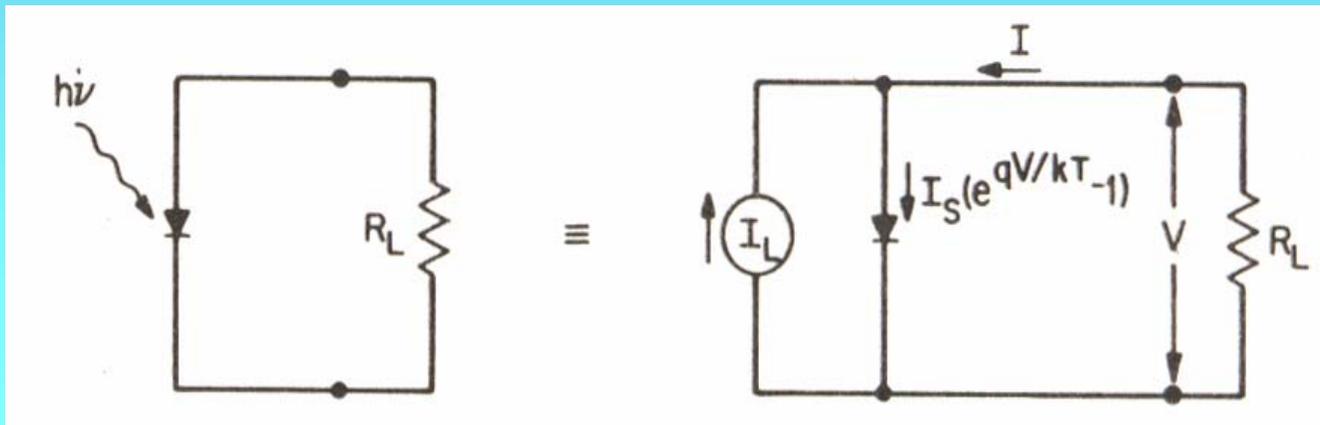
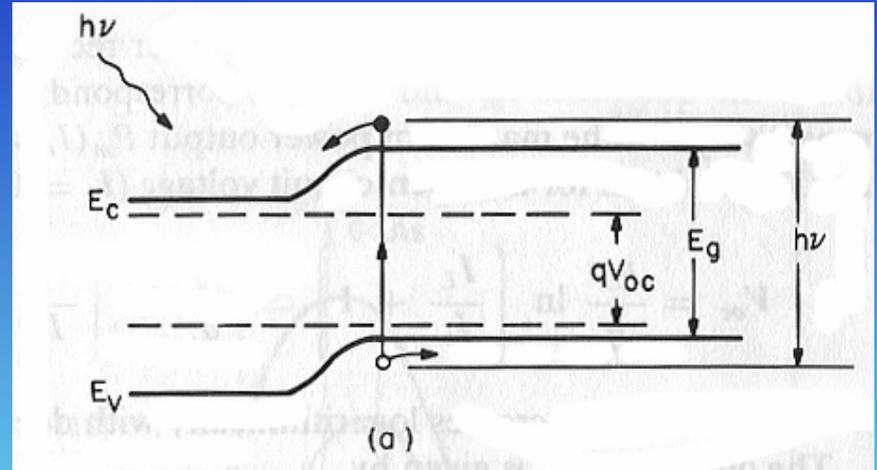
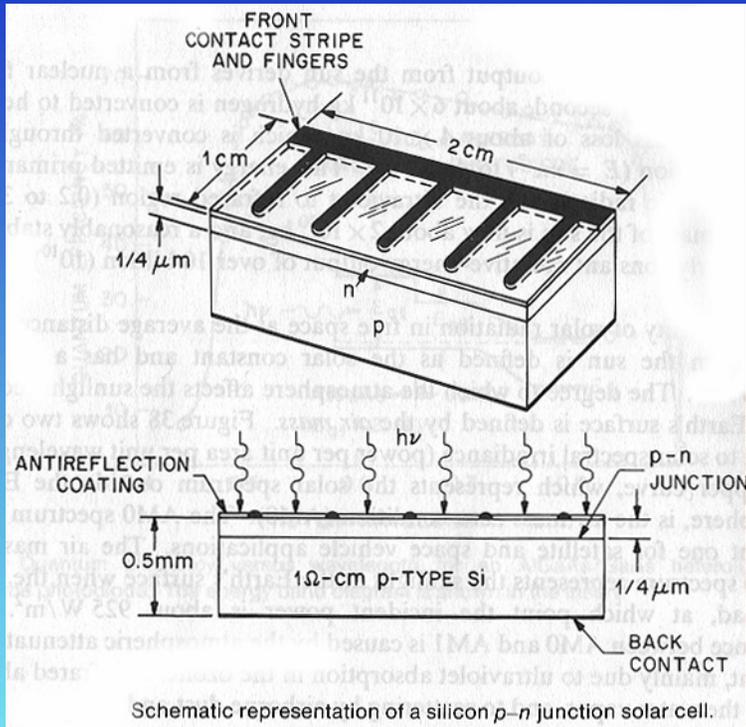
Avalanche-photodiode (APD)



Solar Energy



Solar cell



Photovoltaic power – solar cell

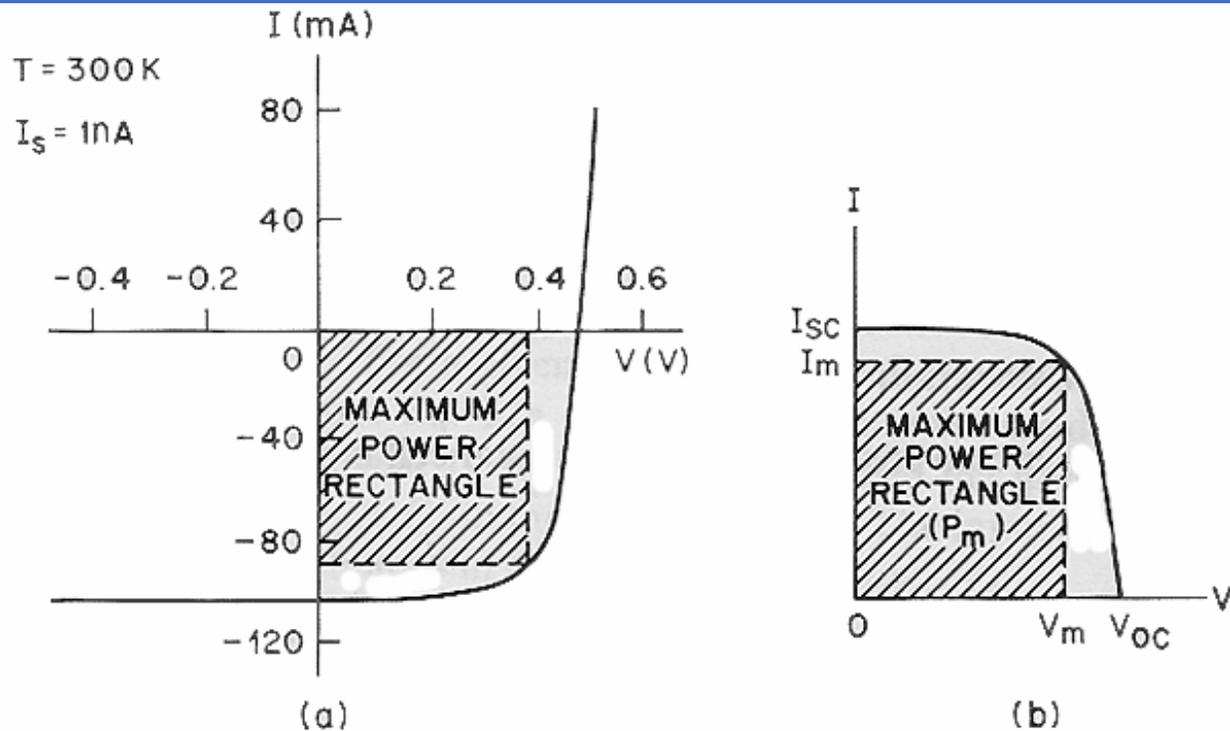
$$I = I_S \left(e^{\frac{qV}{k_B T}} - 1 \right) - I_L$$

$$V_{OC} = \frac{k_B T}{q} \ln \left(\frac{I_L}{I_S} + 1 \right)$$

$$P = IV = I_S V \left(e^{\frac{qV}{k_B T}} - 1 \right) - I_L V$$

$$P_M \cong I_L \left[V_{OC} - \frac{k_B T}{q} \ln \left(1 + \frac{qV_M}{k_B T} \right) - \frac{k_B T}{q} \right]$$

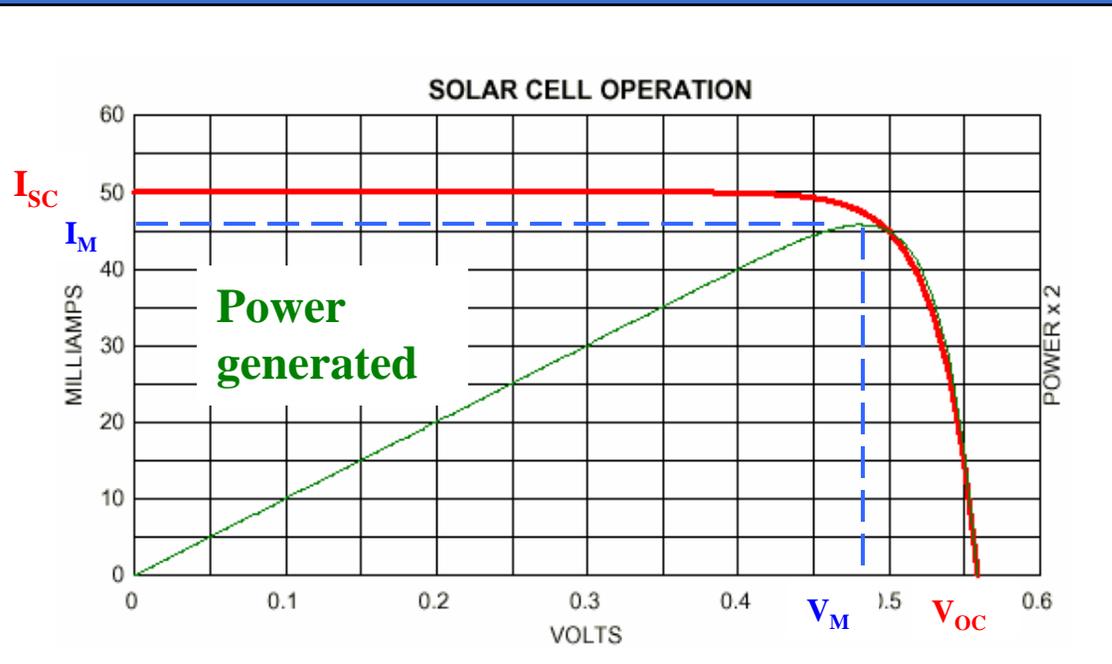
Maximum power generation



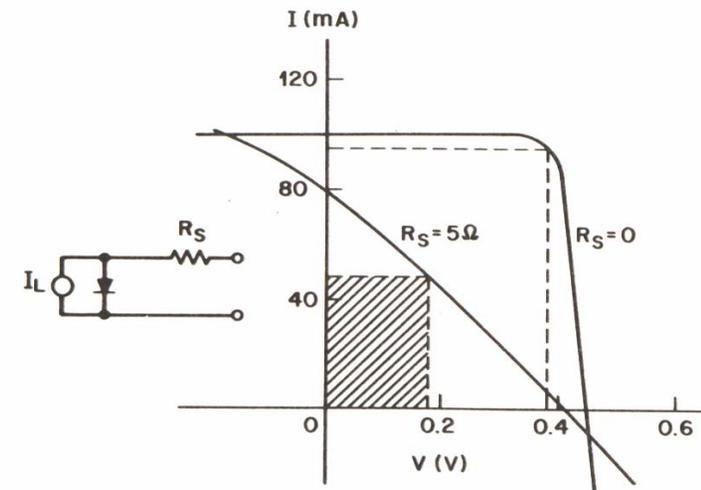
(a) Current-voltage characteristics of a solar cell under illumination. (b) Inversion of (a) about the voltage axis.

Maximum power generation

ideal



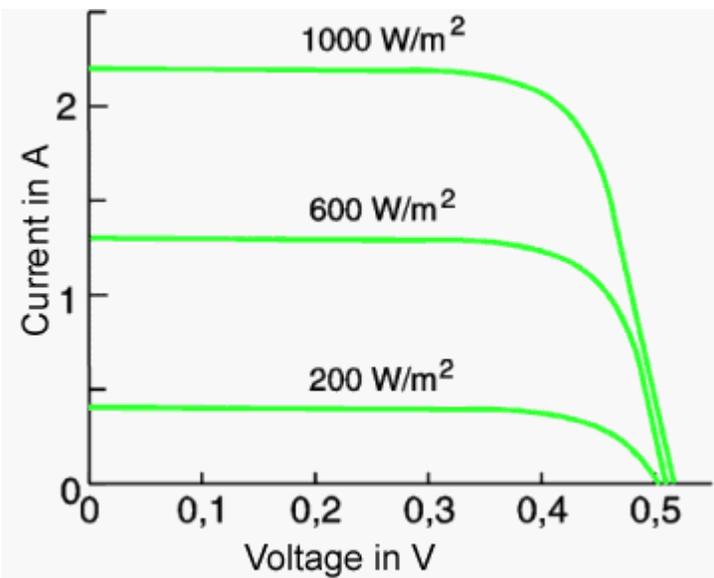
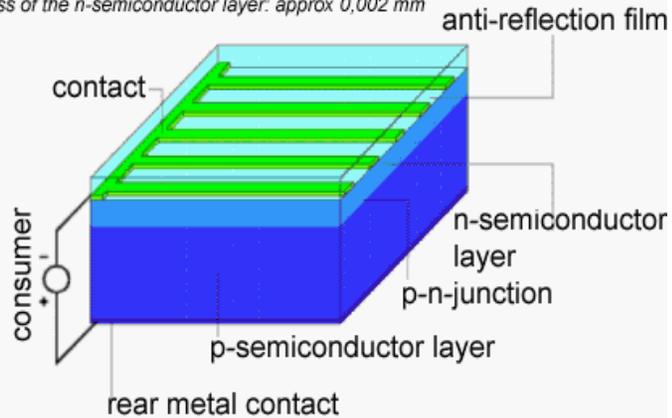
with contact resistance ...



Real Solar Cells

thickness of the solar cell: approx 0,3 mm

thickness of the n-semiconductor layer: approx 0,002 mm



Efficiency of real solar cells

Material	Level of efficiency in % Lab	Level of efficiency in % Production
Monocrystalline Silicon	~ 24 (28% theoretical max)	14 to 17
Polycrystalline Silicon	~ 18	13 to 15
Amorphous Silicon	~ 13	5 to 7